

SOLICITATION/CONTRACT/ORDER FOR COMMERCIAL ITEMS
OFFEROR TO COMPLETE BLOCKS 12, 17, 23, 24, & 30

1. REQUISITION NUMBER
SAP#100000702

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N66001-02-D-0020

3. AWARD/EFFECTIVE DATE
See Block 31C

4. ORDER NUMBER

5. SOLICITATION NUMBER
N66001-02-Q-0020

6. SOLICITATION ISSUE DATE
05-01-2002

7. FOR INFORMATION CALL:

a. NAME
AL NAVASCA/Contract Specialist

b. TELEPHONE NUMBER (No collect calls)
619 553 4506

8. OFFER DUE DATE:
06-12-2002
1600 Pacific Time

9. ISSUED BY
CONTRACTING OFFICER
SPAWARSSYSCEN SAN DIEGO
CONTRACTS CODE 2212
53560 HULL ST.
SAN DIEGO, CA. 92152-5001
Attn: AL NAVASCA (619) 553 4506
Email: al.navasca@navy.mil

10. THIS ACQUISITION IS
 UNRESTRICTED
 SET ASIDE % FOR
 SMALL BUSINESS
 SMALL DISADV. BUSINESS
 8(A)
SIC: 811219
SIZE STANDARD: SSM

11. DELIVERY FOR
FOB DESTINATION
 SEE SCHEDULE

12. DISCOUNT TERMS
NET 30

13a. THIS CONTRACT IS A RATED ORDER UNDER DPAS (15 CFR 700)

13b. RATING

14. METHOD OF SOLICITATION
 RFP IFB RFP

15. DELIVER TO
Receiving Officer
SSC San Diego, Code 2242
53560 Hull Street, San Diego 92152

16. ADMINISTERED BY
SAME AS BLOCK 9

17a. CONTRACTOR/ CODE 32826 FACILITY
Du Pont Photomasks, Inc.
1901 East Morgan Street.
Kokomo, Indiana 46904-4088

18a. PAYMENT WILL BE MADE BY
TO BE DETERMINED ON INDIVIDUAL ORDERS

FOR PLACING ORDERS - SEE NEXT PAGE
 17b. CHECK IF REMITTANCE IS DIFFERENT AND PUT SUCH ADDRESS IN OFFER

18b. SUBMIT INVOICES TO ADDRESS SHOWN IN BLOCK 18a UNLESS BLOCK BELOW IS CHECKED
 SEE ADDENDUM

19. ITEM NO.	20. SCHEDULE OF SUPPLIES/SERVICES	21. QUANTITY	22. UNIT	23. UNIT PRICE	24. AMOUNT
	SEE PAGE 2				\$5,338 (minimum guarantee)
	DUNS: 196368211				

25. ACCOUNTING AND APPROPRIATION DATA
See Page 12

26. TOTAL AWARD AMOUNT (For Govt. Use Only)
\$5,338.00 (See Page 12)

27a. SOLICITATION INCORPORATES BY REFERENCE FAR 52.212-1, 52.212-4. FAR 52.212-3 AND 52.212-5 ARE ATTACHED. ADDENDA ARE ARE NOT ATTACHED.

28. CONTRACTOR IS REQUIRED TO SIGN THIS DOCUMENT AND RETURN 1 COPY TO ISSUING OFFICE. CONTRACTOR AGREES TO FURNISH AND DELIVER ALL ITEMS SET FORTH OR OTHERWISE IDENTIFIED ABOVE AND ON ANY ADDITIONAL SHEETS SUBJECT TO THE TERMS AND CONDITIONS SPECIFIED HEREIN.

29. AWARD OF CONTRACT: REFERENCE OFFER DATED ____, YOUR OFFER ON SOLICITATION (BLOCK 5), INCLUDING ANY ADDITIONS OR CHANGES WHICH ARE SET FORTH HEREIN, IS ACCEPTED TO ITEMS:

30a. SIGNATURE OF OFFEROR/CONTRACTOR
[Signature]

31a. UNITED STATES OF AMERICA (SIGNATURE OF CONTRACTING OFFICER)
[Signature]

30b. NAME AND TITLE OF SIGNER (TYPE OR PRINT)
Account Manager

31b. NAME OF CONTRACTING OFFICER (TYPE OR PRINT)
LINDA MULLIGAN

31c. DATE SIGNED
8/16/2002

32a. QUANTITY IN COLUMN 21 HAS BEEN
 RECEIVED INSPECTED ACCEPTED, EXCEPT AS NOTED

33. SHIP NUMBER
PARTIAL FINAL

34. VOUCHER NUMBER

35. AMOUNT VERIFIED CORRECT FOR

32b. SIGNATURE OF AUTHORIZED GOVT. REPRESENTATIVE

36. PAYMENT
 COMPLETE PARTIAL FINAL

37. CHECK NUMBER

41a. I CERTIFY THIS ACCOUNT IS CORRECT AND PROPER FOR PAYMENT

38. S/R ACCOUNT NUMBER

39. S/R VOUCHER NUMBER

40. PAID BY

41b. SIGNATURE AND TITLE OF CERTIFYING OFFICER

42a. RECEIVED BY (Print)
42b. RECEIVED AT (Location)

42c. DATE RECD (YY/MM/DD)

42d. TOTAL CONTAINERS

N66001-02-D-0020

I. Continuation of SF 1449, Block 17a –Contractor’s Address for Delivery Orders:

Dupont Photomasks, Inc.
 1901 East Morgan Street
 Kokomo, Indiana 46904-4088
 Attn: Barry Jolliffe, Customer Service, Tel 765 854 7546, email: barry.jolliffe@photomask.com
 Jeri Cunningham, Account Manager, Tel. 714 744 5744, email: jeri.cunningham@photomask.com

II. Continuation of SF1449, Blocks 19 through 24:

The contractor shall provide the following items:

BASE PERIOD - ONE YEAR The estimated quantities may be exceeded; however, orders in the base year cannot exceed the cumulative maximum amount.

CLIN	ITEM	ESTIMATED QUANTITY	UNIT PRICE	TOTAL
0001	Photolithographic reticles for GCA XLS Model 7300 I-line stepper	EA		
0001AA	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.20 micron, registration ±0.25 micron.	40	\$1,000.00	\$40,000.00
0001AB	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.50 micron, registration ±0.25 micron.	10	\$1,000.00	\$10,000.00
0001AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the reticle, and inspections as required.	0	N/C	N/C
0001AD	Double sided pellicle as required and in accordance with section C.	50	\$100.00	\$5,000.00
0001AE	Repellicization, as required, in accordance with section C.	0	\$350.00	\$0

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0002	Photolithographic masks for Karl SUSS MA150CC Aligner	EA		
0002AA	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 10.0 micron minimum critical dimension, tolerance \pm 0.50 micron, range 0.50 micron, address size 0.50 micron, registration \pm 0.25 micron.	10	\$1,545.00	\$15,400.00
0002AB	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 2.0 micron minimum critical dimension, tolerance \pm 0.20 micron, range 0.25 micron, address size 0.25 micron, registration \pm 0.25 micron.	0	\$1,450.00	\$0
0002AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0003	Photolithographic reticles for Canon FPA-3000EX4 Stepper			
0003AA	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance \pm 0.125 micron, range 0.125 micron, address size 0.25 micron, registration \pm 0.25 micron.	35	\$1,500.00	\$52,500.00
0003AB	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance \pm 0.05 micron, range 0.075 micron, address size 0.25 micron, registration \pm 0.15 micron.	20	\$2,225.00	\$44,500.00
0003AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0003AD	Double sided pellicle as required and in accordance with section C.	50	\$150.00	\$7,000.00
0003AE	Repellicization, as required, in accordance with section C.	5	\$ 450.00	\$ 2,250.00
			CUMULATIVE MAXIMUM:	\$106,750.00
0004	Data IAW CDRL, DD1423, Exhibit A		NSP*	NSP*

*Not separately priced

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OPTION I – YEAR 2

The estimated quantities may be exceeded; however, orders in the Option year cannot exceed the cumulative maximum amount.

CLIN	ITEM	ESTIMATED QUANTITY	UNIT PRICE	TOTAL
0005	Photolithographic masks for GCA XLS Model 7300 I-line stepper	EA		
0005AA	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.20 micron, registration ± 0.25 micron.	40	\$1,050.00	\$42,000.00
0005AB	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1,050.00	\$10,500.00
0005AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the reticle, and inspections as required.	0	N/C	N/C
0005AD	Double sided pellicle as required and in accordance with section C.	50	\$100.00	\$5,000.00
0005AE	Repellicization, as required, in accordance with section C.	0	\$350.00	\$0
0006	Photolithographic masks for Karl SUSS MA150CC Aligner	EA		
0006AA	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 10.0 micron minimum critical dimension, tolerance ± 0.50 micron, range 0.50 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1,625.00	\$16,250.00
0006AB	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 2.0 micron minimum critical dimension, tolerance ± 0.20 micron, range 0.25 micron, address size 0.25 micron, registration ± 0.25 micron.	0	\$1,625.00	\$0

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0006AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0007	Photolithographic masks for Canon FPA-3000EX4 stepper			
0007AA	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.125 micron, range 0.125 micron, address size 0.25 micron, registration ± 0.25 micron.	35	\$1,575.00	\$55,125.00
0007AB	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.05 micron, range 0.075 micron, address size 0.25 micron, registration ± 0.15 micron.	20	\$2,375.00	\$47,500.00
0007AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0007AD	Double sided pellicle as required and in accordance with section C.	50	\$150.00	\$7,500.00
0007AE	Repellicization, as required, in accordance with section C.	5	\$ 450.00	\$ 2,250.00
			CUMULATIVE MAXIMUM:	\$186,125.00
0008	Data IAW CDRL, DD1423, Exhibit A		NSP*	NSP*

*Not separately priced

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OPTION II – YEAR 3

The estimated quantities may be exceeded; however, orders in the Option year cannot exceed the cumulative maximum amount.

CLIN	ITEM	ESTIMATED QUANTITY	UNIT PRICE	TOTAL
0009	Photolithographic masks for GCA XLS Model 7300 I-line stepper			
0009AA	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.20 micron, registration ± 0.25 micron.	40	\$1,050.00	\$42,000.00
0009AB	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1,050.00	\$10,500.00
0009AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the reticle, and inspections as required.	0	N/C	N/C
0009AD	Double sided pellicle as required and in accordance with section C.	50	\$100.00	\$5,000.00
0009AE	Repellicization, as required, in accordance with section C.	0	\$350.00	\$0
0010	Photolithographic masks for Karl SUSS MA150CC Aligner			
0010AA	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 10.0 micron minimum critical dimension, tolerance ± 0.50 micron, range 0.50 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1625.00	\$16,200.00
0010AB	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 2.0 micron minimum critical dimension, tolerance ± 0.20 micron, range 0.25 micron, address size 0.25 micron, registration ± 0.25 micron.	0	\$1,625.00	\$0

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0010AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0011	Photolithographic masks for Canon FPA-3000EX4 stepper			
0011AA	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.125 micron, range 0.125 micron, address size 0.25 micron, registration ± 0.25 micron.	35	\$1,575.00	\$55,125.00
0011AB	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.05 micron, range 0.075 micron, address size 0.25 micron, registration ± 0.15 micron.	20	\$2,375.00	\$47,500.00
0011AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0011AD	Double sided pellicle as required and in accordance with section C.	50	\$ 150.00	\$ 7,500.00
0011AE	Repellicization, as required, in accordance with section C.	5	\$ 450.00	\$ 2,250.00
			CUMULATIVE MAXIMUM:	\$186,125.00
0012	Data ISW CDRL, DD1423, Exhibit A		NSP*	NSP*

*Not separately priced

OPTION III – YEAR 4

The estimated quantities may be exceeded; however, orders in the Option year cannot exceed the cumulative maximum amount.

CLIN	ITEM	ESTIMATED QUANTITY	UNIT PRICE	TOTAL
0013	Photolithographic masks for GCA XLS Model 7300 I-line stepper			
0013AA	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.20 micron, registration ± 0.25 micron.	40	\$1,200.00	\$48,000.00
0013AB	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance ± 0.25 micron, range 0.25 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1,200.00	\$12,000.00
0013AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the reticle, and inspections as required.	0	N/C	N/C
0013AD	Double sided pellicle as required and in accordance with section C.	50	\$100.00	\$5,000.00
0013AE	Repellicization, as required, in accordance with section C.	0	\$350.00	\$0
0014	Photolithographic masks for Karl SUSS MA150CC Aligner			
0014AA	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 10.0 micron minimum critical dimension, tolerance ± 0.50 micron, range 0.50 micron, address size 0.50 micron, registration ± 0.25 micron.	10	\$1,700.00	\$17,000.00
0014AB	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 2.0 micron minimum critical dimension, tolerance ± 0.20 micron, range 0.25 micron, address size 0.25 micron, registration ± 0.25 micron.	0	\$1,700.00	\$0

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0014AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0015	Photolithographic masks for Canon FPA-3000EX4 stepper			
0015AA	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.125 micron, range 0.125 micron, address size 0.25 micron, registration ± 0.25 micron.	35	\$1,650.00	\$57,750.00
0015AB	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.05 micron, range 0.075 micron, address size 0.25 micron, registration ± 0.15 micron.	20	\$2,450.00	\$49,000.00
0015AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0015AD	Double sided pellicle as required and in accordance with section C.	50	\$150.00	\$7,500.00
0015AE	Repellicization, as required, in accordance with section C.	5	\$450.00	\$2,250.00
			CUMULATIVE MAXIMUM:	\$198,000.00
0016	Data IAW CDRL, DD1423, Exhibit A		NSP*	NSP*

*Not separately priced

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OPTION IV – YEAR 5

The estimated quantities may be exceeded; however, orders in the Option year cannot exceed the cumulative maximum amount.

CLIN	ITEM	ESTIMATED QUANTITY	UNIT PRICE	TOTAL
0017	Photolithographic masks for GCA XLS Model 7300 I-line stepper			
0017AA	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance \pm 0.25 micron, range 0.25 micron, address size 0.20 micron, registration \pm 0.25 micron.	40	\$1,200.00	\$48,000.00
0017AB	Reticle, 0.090 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 2.0 micron minimum critical dimension, tolerance \pm 0.25 micron, range 0.25 micron, address size 0.50 micron, registration \pm 0.25 micron.	10	\$1,200.00	\$12,000.00
0017AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the reticle, and inspections as required.	0	N/C	N/C
0017AD	Double sided pellicle as required and in accordance with section C.	50	\$100.00	\$5,000.00
0017AE	Repellicization, as required, in accordance with section C.	0	\$350.00	\$0
0018	Photolithographic masks for Karl SUSS MA150CC Aligner			
0018AA	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 10.0 micron minimum critical dimension, tolerance \pm 0.50 micron, range 0.50 micron, address size 0.50 micron, registration \pm 0.25 micron.	10	\$1,700.00	\$17,000.00
0018AB	Mask, 0.150 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair. 2.0 micron minimum critical dimension, tolerance \pm 0.20 micron, range 0.25 micron, address size 0.25 micron, registration \pm 0.25 micron.	0	\$1,700.00	\$0

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0018AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0019	Photolithographic masks for Canon FPA-3000EX4 stepper			
0019AA	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.125 micron, range 0.125 micron, address size 0.25 micron, registration ± 0.25 micron.	35	\$1,650.00	\$57,750.00
0019AB	Reticle, 0.250 inch thick, including data fracture of up to 4 die per layer, defect inspection and repair, barcode generation. 1.25 micron minimum critical dimension, tolerance ± 0.05 micron, range 0.075 micron, address size 0.25 micron, registration ± 0.15 micron.	20	\$2,450.00	\$49,000.00
0019AC	Charge per extra data file conversion above 4 die per layer, to include extra data fractures, placement of each data file in proper location on the mask, and inspections as required.	0	N/C	N/C
0019AD	Double sided pellicle as required and in accordance with section C.	50	\$150.00	\$7,500.00
0019AE	Repellicization, as required, in accordance with section C.	5	\$450.00	\$2,250.00
			CUMULATIVE MAXIMUM:	\$198,000.00
0020	Data IAW CDRL, DD1423, Exhibit A		NSP*	NSP*

*Not separately priced

III. SF 1449, Block 25 is completed as follows:

Requisition Item Number: 1000000702
Tracking Number: N66001-1346-87601
WBS Number: G-00032-SP:DOM

AA 97X4930 NH3P 000 77777 0 066001 2F 000000 1000000702AA \$5,338.00 (MINIMUM GUARANTEE)

IV. Applicable Contract Clauses:

(1) FAR 52.212-4 Contract Terms and Conditions – Commercial Items (Feb 2002) (Addendum)

Invoices are to be sent in accordance with FAR 52.212-4(g) to the following address:
Space and Naval Warfare Systems Center San Diego (SSC SD), P.O. Box 80818, San Diego, CA 92138-0818

(2) FAR 52.216-18 – Ordering (Oct 1995)

(a) Any supplies and services to be furnished under this contract shall be ordered by issuance of delivery orders or task orders by the individuals or activities designated in the Schedule. Such orders may be issued from the date of contract award through 12 months thereafter.

(b) All delivery orders or task orders are subject to the terms and conditions of this contract. In the event of conflict between a delivery order or task order and this contract, the contract shall control.

(c) If mailed, a delivery order or task order is considered "issued" when the Government deposits the order in the mail. Orders may be issued orally, by facsimile, or by electronic commerce methods only if authorized in the Schedule.

(3) FAR 52.216-19 – Order Limitations (Oct 1995) (IBR authorized)

(a) *Minimum order.* When the Government requires supplies or services covered by this contract in an amount of less than one, the Government is not obligated to purchase, nor is the Contractor obligated to furnish, those supplies or services under the contract.

(b) *Maximum order.* The Contractor is not obligated to honor --

(1) Any order for a single item in excess of 4,000;

(2) Any order for a combination of items in excess of 12,000; or

(3) A series of orders from the same ordering office within 14 days that together call for quantities exceeding the limitation in subparagraph (b)(1) or (2) of this section.

(c) If this is a requirements contract (*i.e.*, includes the Requirements clause at subsection 52.216-21 of the Federal Acquisition Regulation (FAR)), the Government is not required to order a part of any one requirement from the Contractor if that requirement exceeds the maximum-order limitations in paragraph (b) of this section.

(d) Notwithstanding paragraphs (b) and (c) of this section, the Contractor shall honor any order exceeding the maximum order limitations in paragraph (b), unless that order (or orders) is returned to the ordering office within five (5) days after issuance, with written notice stating the Contractor's intent not to ship the item (or items) called for and the reasons. Upon receiving this notice, the Government may acquire the supplies or services from another source.

FAR 52.216-22 — Indefinite Quantity (Oct 1995)

(a) This is an indefinite-quantity contract for the supplies or services specified, and effective for the period stated, in the Schedule. The quantities of supplies and services specified in the Schedule are estimates only and are not purchased by this contract.

(b) Delivery or performance shall be made only as authorized by orders issued in accordance with the Ordering clause. The Contractor shall furnish to the Government, when and if ordered, the supplies or services specified in the Schedule up to and including the quantity designated in the Schedule as the "maximum." The Government shall order at least the quantity of supplies or services designated in the Schedule as the "minimum."

(c) Except for any limitations on quantities in the Order Limitations clause or in the Schedule, there is no limit on the number of orders that may be issued. The Government may issue orders requiring delivery to multiple destinations or performance at multiple locations.

(d) Any order issued during the effective period of this contract and not completed within that period shall be completed by the Contractor within the time specified in the order. The contract shall govern the Contractor's and Government's rights and obligations with respect to that order to the same extent as if the order were completed during the contract's effective period; provided, that the Contractor shall not be required to make any deliveries under this contract after 120 days.

MINIMUM AND MAXIMUM OBLIGATION

As referred to in paragraph (b) of FAR 52.216-22, "Indefinite Quantity", of this contract, the minimum to be ordered is 5% of the contract ceiling amount for the base year. The maximum obligation is the contract ceiling amount. The maximum amount is not to be exceeded without prior approval of the Procuring Contracting Officer.

FAR 52.217-9 – Option to Extend the Term of the Contract (Mar 2000)

(a) The Government may extend the term of this contract by written notice to the Contractor within 60 days provided, that the Government gives the Contractor a preliminary written notice of its intent to extend at least 60 days before the contract expires. The preliminary notice does not commit the Government to an extension.

(b) If the Government exercises this option, the extended contract shall be considered to include this option clause.

(c) The total duration of this contract, including the exercise of any options under this clause, shall not exceed 60 months.

FAR 52.212-5 – Contract Terms and Conditions Required to Implement Statutes or Executive Orders – Commercial Items (Dec 2001)

(a) The Contractor shall comply with the following FAR clauses, which are incorporated in this contract by reference, to implement provisions of law or executive orders applicable to acquisitions of commercial items:

(1) 52.222-3, Convict Labor (E.O. 11755);

(2) 52.233-3, Protest after Award (31 U.S.C 3553).

(b) The Contractor shall comply with the FAR clauses in this paragraph (b) that the contracting officer has indicated as being incorporated in this contract by reference to implement provisions of law or Executive orders applicable to acquisitions of commercial items or components:

[Contracting Officer shall check as appropriate.]

(1) 52.203-6, Restrictions on Subcontractor Sales to the Government, with Alternate I (41 U.S.C. 253g and 10 U.S.C. 2402).

(2) 52.219-3, Notice of HUBZone Small Business Set-Aside (Jan 1999).

(3) 52.219-4, Notice of Price Evaluation Preference for HUBZone Small Business Concerns (Jan 1999) (if the offeror elects to waive the preference, it shall so indicate in its offer).

(4) (i) 52.219-5, Very Small Business Set-Aside (Pub. L. 103-403, section 304, Small Business Reauthorization and Amendments Act of 1994).

(ii) Alternate I to 52.219-5.

(iii) Alternate II to 52.219-5.

(5) 52.219-8, Utilization of Small Business Concerns (15 U.S.C. 637 (d)(2) and (3)).

(6) 52.219-9, Small Business Subcontracting Plan (15 U.S.C. 637 (d)(4)).

(7) 52.219-14, Limitations on Subcontracting (15 U.S.C. 637(a)(14)).

(8) (i) 52.219-23, Notice of Price Evaluation Adjustment for Small Disadvantaged Business Concerns (Pub. L. 103-355, section 7102, and 10 U.S.C. 2323) (if the offeror elects to waive the adjustment, it shall so indicate in its offer).

(ii) Alternate I of 52.219-23.

(9) 52.219-25, Small Disadvantaged Business Participation Program-Disadvantaged Status and Reporting (Pub. L. 103-355, section 7102, and 10 U.S.C. 2323).

(10) 52.219-26, Small Disadvantaged Business Participation Program-Incentive Subcontracting (Pub. L. 103-355, section 7102, and 10 U.S.C. 2323).

(11) 52.222-21, Prohibition of Segregated Facilities (Feb 1999).

(12) 52.222-26, Equal Opportunity (E.O. 11246).

(13) 52.222-35, Equal Opportunity for Special Disabled Veterans, Veterans of the Vietnam Era, and Other Eligible Veterans (38 U.S.C. 4212).

(14) 52.222-36, Affirmative Action for Workers with Disabilities (29 U.S.C. 793).

(15) 52.222-37, Employment Reports on Special Disabled Veterans, Veterans of the Vietnam Era, and Other Eligible Veterans (38 U.S.C. 4212).

(16) 52.222-19, Child Labor-Cooperation with Authorities and Remedies (E.O. 13126).

(17)(i) 52.223-9, Estimate of Percentage of Recovered Material Content for EPA-Designated Products (42 U.S.C. 6962(c)(3)(A)(ii)).

(ii) Alternate I of 52.223-9 (42 U.S.C. 6962(i)(2)(C)).

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- (18) 52.225-1, Buy American Act-Balance of Payments Program-Supplies (41 U.S.C. 10a-10d).
- (19)(i) 52.225-3, Buy American Act - North American Free Trade Agreement - Israeli Trade Act - Balance of Payments Program (41 U.S.C. 10a-10d, 19 U.S.C. 3301 note, 19 U.S.C. 2112 note).
- (ii) Alternate I of 52.225-3.
- (iii) Alternate II of 52.225-3.
- (20) 52.225-5, Trade Agreements (19 U.S.C. 2501, *et seq.*, 19 U.S.C. 3301 note).
- (21) 52.225-13, Restriction on Certain Foreign Purchases (E.O. 12722, 12724, 13059, 13067, 13121, and 13129).
- (22) 52.225-15, Sanctioned European Union Country End Products (E.O. 12849).
- (23) 52.225-16, Sanctioned European Union Country Services (E.O. 12849).
- (24) 52.232-33, Payment by Electronic Funds Transfer-Central Contractor Registration (31 U.S.C. 3332).
- (25) 52.232-34, Payment by Electronic Funds Transfer-Other Than Central Contractor Registration (31 U.S.C. 3332).
- (26) 52.232-36, Payment by Third Party (31 U.S.C. 3332).
- (27) 52.239-1, Privacy or Security Safeguards (5 U.S.C. 552a).
- (28) (i) 52.247-64, Preference for Privately Owned U.S.-Flag Commercial Vessels (46 U.S.C. 1241).
- (ii) Alternate I of 52.247-64.

(c) The Contractor shall comply with the FAR clauses in this paragraph (c), applicable to commercial services, which the Contracting Officer has indicated as being incorporated in this contract by reference to implement provisions of law or executive orders applicable to acquisitions of commercial items or components:

[Contracting Officer check as appropriate.]

- (1) 52.222-41, Service Contract Act of 1965, As Amended (41 U.S.C. 351, *et seq.*).
- (2) 52.222-42, Statement of Equivalent Rates for Federal Hires (29 U.S.C. 206 and 41 U.S.C. 351, *et seq.*).
- (3) 52.222-43, Fair Labor Standards Act and Service Contract Act -- Price Adjustment (Multiple Year and Option Contracts) (29 U.S.C.206 and 41 U.S.C. 351, *et seq.*).
- (4) 52.222-44, Fair Labor Standards Act and Service Contract Act -- Price Adjustment (29 U.S.C. 206 and 41 U.S.C. 351, *et seq.*).
- (5) 52.222-47, SCA Minimum Wages and Fringe Benefits Applicable to Successor Contract Pursuant to Predecessor Contractor Collective Bargaining Agreement (CBA) (41 U.S.C. 351, *et seq.*).

(d) *Comptroller General Examination of Record.* The Contractor shall comply with the provisions of this paragraph (d) if this contract was awarded using other than sealed bid, is in excess of the simplified acquisition threshold, and does not contain the clause at 52.215-2, Audit and Records -- Negotiation.

(1) The Comptroller General of the United States, or an authorized representative of the Comptroller General, shall have access to and right to examine any of the Contractor's directly pertinent records involving transactions related to this contract.

(2) The Contractor shall make available at its offices at all reasonable times the records, materials, and other evidence for examination, audit, or reproduction, until 3 years after final payment under this contract or for any shorter period specified in FAR Subpart 4.7, Contractor Records Retention, of the other clauses of this contract. If this contract is completely or partially terminated, the records relating to the work terminated shall be made available for 3 years after any resulting final termination settlement. Records relating to appeals under the disputes clause or to litigation or the settlement of claims arising under or relating to this contract shall be made available until such appeals, litigation, or claims are finally resolved.

(3) As used in this clause, records include books, documents, accounting procedures and practices, and other data, regardless of type and regardless of form. This does not require the Contractor to create or maintain any record that the Contractor does not maintain in the ordinary course of business or pursuant to a provision of law.

(e) Notwithstanding the requirements of the clauses in paragraphs (a), (b), (c) or (d) of this clause, the Contractor is not required to include any FAR clause, other than those listed below (and as may be required by an addenda to this paragraph to establish the reasonableness of prices under Part 15), in a subcontract for commercial items or commercial components --

(1) 52.222-26, Equal Opportunity (E.O. 11246);

(2) 52.222-35, Equal Opportunity for Special Disabled Veterans, Veterans of the Vietnam Era, and Other Eligible Veterans (38 U.S.C. 4212);

(3) 52.222-36, Affirmative Action for Workers with Disabilities (29 U.S.C. 793);

(4) 52.247-64, Preference for Privately-Owned U.S. Flag Commercial Vessels (46 U.S.C. 1241) (flow down not required for subcontracts awarded beginning May 1, 1996); and

(5) 52.222-41, Service Contract Act of 1965, As Amended (41 U.S.C. 351, *et seq.*).

DFARS 252.212-7001 – Contract Terms and Conditions Required to Implement Statutes or Executive Orders Applicable to Defense Acquisitions of Commercial Items (NOV 2001)

(a) The Contractor agrees to comply with the following Federal Acquisition Regulation (FAR) clause which, if checked, is included in this contract by reference to implement a provision of law applicable to acquisitions of commercial items or components.

52.203-3 Gratuities (APR 1984) (10 U.S.C. 2207)

(b) The Contractor agrees to comply with any clause that is checked on the following list of Defense FAR Supplement clauses which, if checked, is included in this contract by reference to implement provisions of law or Executive orders applicable to acquisitions of commercial items or components.

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<input type="checkbox"/>	252.205-7000	Provision of Information to Cooperative Agreement Holders (DEC 1991) (10 U.S.C. 2416).
<input type="checkbox"/>	252.206-7000	Domestic Source Restriction (DEC 1991) (10 U.S.C. 2304).
<input checked="" type="checkbox"/>	252.219-7003	Small, Small Disadvantaged and Women-Owned Small Business Subcontracting Plan (DoD Contracts) (APR 1996) (15 U.S.C. 637).
<input type="checkbox"/>	252.219-7004	Small, Small Disadvantaged and Women-Owned Small Business Subcontracting Plan (Test Program) (JUN 1997) (15 U.S.C. 637 note).
<input checked="" type="checkbox"/>	252.225-7001	Buy American Act and Balance of Payments Program (MAR 1998) (41 U.S.C. 10a-10d, E.O. 10582).
<input type="checkbox"/>	252.225-7007	Buy American Act--Trade Agreements--Balance of Payments Program (SEP 2001) (41 U.S.C. 10a-10d, 19 U.S.C. 2501-2518, and 19 U.S.C. 3301 note).
<input checked="" type="checkbox"/>	252.225-7012	Preference for Certain Domestic Commodities (AUG 2000) (10 U.S.C. 2241 note).
<input type="checkbox"/>	252.225-7014	Preference for Domestic Specialty Metals (MAR 1998) (10 U.S.C. 2241 note).
<input type="checkbox"/>	252.225-7015	Preference for Domestic Hand or Measuring Tools (DEC 1991) (10 U.S.C. 2241 note).
<input type="checkbox"/>	252.225-7016	Restriction on Acquisition of Ball and Roller Bearings (DEC 2000) (<input type="checkbox"/> Alternate I) (DEC 2000) (Section 8064 of Pub. L. 106-259).
<input type="checkbox"/>	252.225-7021	Trade Agreements (SEP 2001) (19 U.S.C. 2501-2518 and 19 U.S.C. 3301 note).
<input type="checkbox"/>	252.225-7027	Restriction on Contingent Fees for Foreign Military Sales (MAR 1998) (22 U.S.C. 2779).
<input type="checkbox"/>	252.225-7028	Exclusionary Policies and Practices of Foreign Governments (DEC 1991) (22 U.S.C. 2755).
<input type="checkbox"/>	252.225-7029	Preference for United States or Canadian Air Circuit Breakers (AUG 1998) (10 U.S.C. 2534(a)(3)).
<input type="checkbox"/>	252.225-7036	Buy American Act--North American Free Trade Agreement Implementation Act--Balance of Payments Program (MAR 1998) (<input type="checkbox"/> Alternate I) (SEP 1999) (41 U.S.C. 10a-10d and 19 U.S.C. 3301 note).
<input checked="" type="checkbox"/>	252.227-7015	Technical Data--Commercial Items (NOV 1995) (10 U.S.C. 2320).

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- 252.227-7037 Validation of Restrictive Markings on Technical Data (SEP 1999) (10 U.S.C. 2321).
- 252.243-7002 Requests for Equitable Adjustment (MAR 1998) (10 U.S.C. 2410).
- 252.247-7023 Transportation of Supplies by Sea (MAR 2000) (Alternate I) (MAR 2000) (Alternate II) (MAR 2000) (10 U.S.C. 2631).
- 252.247-7024 Notification of Transportation of Supplies by Sea (MAR 2000) (10 U.S.C. 2631).

(c) In addition to the clauses listed in paragraph (e) of the Contract Terms and Conditions Required to Implement Statutes or Executive Orders--Commercial Items clause of this contract (FAR 52.212-5), the Contractor shall include the terms of the following clauses, if applicable, in subcontracts for commercial items or commercial components, awarded at any tier under this contract:

- 252.225-7014 Preference for Domestic Specialty Metals, Alternate I (MAR 1998) (10 U.S.C. 2241 note).
- 252.247-7023 Transportation of Supplies by Sea (MAR 2000) (10 U.S.C. 2631).
- 252.247-7024 Notification of Transportation of Supplies by Sea (MAR 2000) (10 U.S.C. 2631).

**Attachment 1
Section C
Description or Specifications**

Work under this contract shall be performed in accordance with the following specifications, Statement of Work:

C-1.0 GENERAL RETICLE DESCRIPTION

C-1.1. The Integrated Circuit Fabrication Facility (ICFF) at SPAWAR Systems Center, San Diego, (SSCSD) fabricates integrated circuits. To transfer patterns, which define integrated circuit process steps onto wafers, a lithographic process is used. A reticle or photomask is a quartz plate on which these patterns appear as dark areas. A pattern is transferred by shining light through this photomask onto a wafer coated with a photosensitive material. About 8 to 15 photomasks are required to fabricate a single integrated circuit.

C-1.2. RETICLE SPECIFICATIONS

C-1.2.1. Reticles for GCA XLS Model 7300 I-line Stepper

- C-1.2.1.1. The data will be provided by SSCSD in GDSII format at 1X scale, right reading, normal tone, and must be converted by the vendor into the appropriate data format for reticle generation.
- C-1.2.1.2. The CAD grid size will be 0.05 microns.
- C-1.2.1.3. Access to a contractor owned electronic (preferred) site (including use of software such as Maskview™ required to enter the site and view the data) or other means to review the data after conversion will be provided to allow for SSCSD approval prior to reticle generation.
- C-1.2.1.4. The reticle shall be of the 4X reduction type for use in a GCA XLS model 7300 i-line stepper, as described in GCA Document 081249G1 Rev. 2, "XLS Reticle Application Handbook."
- C-1.2.1.5. The reticle substrate shall be quartz, measuring 5 x 5 inches, and shall be 0.090 inches thick.
- C-1.2.1.6. The reticle shall have an antireflective chrome coating.
- C-1.2.1.7. The reticle plate flatness shall be less than or equal to 2 microns.
- C-1.2.1.8. All die on the reticle are to be inspected and compared with the GDSII data.
- C-1.2.1.9. Die registration shall be measured at a minimum of 4 places per reticle by using marks provided in the data. Errors in placement shall be less than ± 0.25 microns with a maximum range of 0.25 microns.
- C-1.2.1.10. Level to level registration shall be less than ± 0.25 microns with a maximum range of 0.25 microns.
- C-1.2.1.11. Critical dimension tolerance shall be less than ± 0.25 microns with a maximum range of 0.25 microns.
- C-1.2.1.12. Barcode will be generated by the vendor.
- C-1.2.1.13. Defects: Any defects larger than 1.0 micron on the reticle shall be repaired free of charge.
- C-1.2.1.14. Upon request, the photomask plate shall be fitted with a double sided pellicle of proper size to fit the reticle and with a film for use with I-line radiation (e.g. Inko part number GCA108.6*7.7-NCF-0-S or equivalent).
- C-1.2.1.15. At the discretion of SSCSD, the reticle will be returned to the vendor, the old pellicle removed, and a new double sided pellicle fitted such as Inko part number GCA108.6*7.7-NCF-0-S or equivalent.

C-1.2.2. Reticles for Karl SUSS MA150CC Aligner

- C-1.2.2.1. The data will be provided by SSCSD in GDSII format at 1X scale, right reading, normal tone, and must be converted by the vendor into the appropriate data format for mask generation.
- C-1.2.2.2. The CAD grid size will be 0.5 microns.
- C-1.2.2.3. Access to a contractor owned electronic (preferred) site (including use of software such as Maskview™ required to enter the site and view the data) or other means to review the data after conversion will be provided to allow for SSCSD approval prior to mask generation.
- C-1.2.2.4. The mask shall be of the 1X master type for use in a Karl SUSS MA150CC Aligner.
- C-1.2.2.5. The mask substrate shall be quartz, measuring 7x 7 inches, and shall be 0.150 inches thick.
- C-1.2.2.6. The pattern shall be comprised of an antireflective chrome coating.
- C-1.2.2.7. The mask plate flatness shall be less than or equal to 2 microns.
- C-1.2.2.8. All die on the mask are to be inspected and compared with the GDSII data.
- C-1.2.2.9. Die registration shall be measured at a minimum of 4 places per mask by using marks provided in the data. Errors in placement shall be less than ± 0.25 microns with a maximum range of 0.25 microns.
- C-1.2.2.10. Level to level registration shall be less than ± 0.25 microns with a maximum range of 0.25 microns.
- C-1.2.2.11. Critical dimension tolerance shall be less than $\pm 0.50/0.20$ microns with a maximum range of 0.50/0.25 microns depending upon the CLIN ordered.
- C-1.2.2.12. Defects: Any defects larger than 2.0 microns on the mask shall be repaired free of charge. Defect density shall be less than 2 per square inch.

C-1.2.3. Reticles for Canon FPA-3000EX4 Stepper

- C-1.2.3.1. The data will be provided by SSCSD in GDSII format at 1X scale, right reading, normal tone, and must be converted by the vendor into the appropriate data format for reticle generation.
- C-1.2.3.2. The CAD grid size will be 0.05 microns.
- C-1.2.3.3. Access to a contractor owned electronic (preferred) site (including use of software such as Maskview™ required to enter the site and view the data) or other means to review the data after conversion will be provided to allow for SSCSD approval prior to photomask generation.
- C-1.2.3.4. The reticle shall be of the 5X reduction type for use in a Canon FPA-3000EX4 DUV stepper, as specified in Canon's FPA-3000 EX4 Reticle Guide (Part #BY8-6189-0E0)
- C-1.2.3.5. The reticle substrate shall be quartz, measuring 6 x 6 inches, and shall be 0.250 inches thick.
- C-1.2.3.6. The reticle shall have an antireflective chrome coating.
- C-1.2.3.7. The reticle plate flatness shall be less than or equal to 2 microns.
- C-1.2.3.8. All die on the reticles are to be inspected and compared with the GDSII data.
- C-1.2.3.9. Die registration shall be measured at a minimum of 4 places per reticle by using marks provided in the data. Errors in placement shall be less than ± 0.25 microns.
- C-1.2.3.10. Level to level registration shall be less than ± 0.25 or ± 0.15 microns as specified in CLIN ordered.
- C-1.2.3.11. Critical dimension tolerance shall be less than ± 0.125 or ± 0.050 microns as specified in CLIN ordered.
- C-1.2.3.12. Critical dimension range shall be less than 0.125 or 0.075 microns as specified in CLIN ordered.
- C-1.2.3.13. Barcode will be generated by the vendor.
- C-1.2.3.14. Plate Defects: Any defects larger than 1.0 micron on the reticle plate shall be repaired free of charge.
- C-1.2.3.15. Upon request, the photomask plate shall be fitted with a double sided pellicle such as Micro-Lithography Incorporated part number CAN56-602-1017 or equivalent.
- C-1.2.3.16. At the discretion of SSCSD, the reticle will be returned to the vendor, the old pellicle removed, and a new double sided pellicle fitted such as Micro-Lithography Incorporated part number CAN56-602-1017 or equivalent.

C-2.0 PERFORMANCE

- C-2.1. A review of the converted data such as access via Maskview™ shall be provided within 5 working days of data delivery from SSCSD.**
- C-2.2. The first 2 reticles of an order shall be shipped to SSCSD within 5 working days after approval of the converted data by SSCSD. All reticles within the order shall be shipped to SSCSD within 10 working days after approval of the data by SSCSD.**
- C-2.3. Replacements for defective or broken reticles must be shipped to SSCSD with 3 working days after the vendor is notified of the problem.**

C-3.0 REPORTS, DATA, DELIVERABLES

- C-3.1. The vendor shall provide all inspection, centrality, defect maps, and reports related to each reticle shipped.**
- C-3.2. Job deck and array plots shall be delivered to SSCSD via FAX and approved prior to photomask generation.**

C-4.0 GOVERNMENT FURNISHED INFORMATION

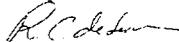
- C-4.1. SSCSD will provide the data required to define the patterns on each reticle ordered.**

**CONTRACT DATA REQUIREMENTS LIST
(2 Data Item)**

**Form Approved
OMB No. 0704-0188**

Public reporting burden for this collection of information is estimated to average 110 hours per response, including the time for reviewing instructions, searching existing data sources, gathering and maintaining the data needed, and completing and reviewing the collection of information. Send comments regarding this burden estimate or any other aspect of this collection of information, including suggestions for reducing this burden, to Department of Defense, Washington Headquarters Services, Directorate for information Operations and Reports, 1215 Jefferson Davis Highway, Suite 1204, Arlington, VA 22202-4302, and to the Office of Management and Budget, Paperwork Reduction Project (0704-0188), Washington, DC 20503. Please DO NOT RETURN your form to either of these addresses. Send completed form to the Government Issuing Contract Officer for the Contract/PR No. listed in Block E.

A. CONTRACT LINE ITEM NO.		B. EXHIBIT A		C. CATEGORY: TDP TM OTHER MISC					
D. SYSTEM/ITEM PHOTOLITHOGRAPHIC MASKS			E. CONTRACT/PR NO. /		F. CONTRACTOR				
1. DATA ITEM NO. A001	2. TITLE OF DATA ITEM Technical Report-Study/Services			3. SUBTITLE Reticle Summary Reports					
4. AUTHORITY DI-MISC-80508		5. CONTRACT REFERENCE SOW Para Sec C-3.0 Attachment 2			6. REQUIRING OFFICE SPAWARSYSCEN SAN DIEGO 2876				
7. DD250 REQ LT	9. DIST STATEMENT See Attachment 1		10. FREQUENCY ASREQ	12. FIRST SUBMISSION SEE BLK 16		14. DISTRIBUTION			
8. APP CODE N/A			11. AS OF DATE N/A	13. SUBSEQUENT SUBMISSION SEE BLK 16		a. ADDRESSEE	b. COPIES		
					Draft		Reg	Repro	
16. REMARKS Blk 4: Contractor format authorized. Include standard commercial documentation and any inspection, centrality, defect maps and reports related to each reticle. Blks 12 & 13: As required, NLT EOC. Blks 14: Deliver electronically to each addressee via email. Code 2876: houssaye@spawar.navy.mil Code 2213: cdrl@spawar.navy.mil						M/F CODE 2876	0	1	0
						M/F CODE 2213	0	1	0
						15. Total ----->	0	2	0

G. PREPARED BY PAUL DELAHOUSAYE	H. DATE 01/24/2002	I. APPROVED BY  ROSAURO DELEON	J. DATE 04/16/2002
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ATTACHMENT 1
DD-1423

THE CONTRACTOR SHALL APPLY THE FOLLOWING DISTRIBUTION STATEMENT TO EACH DELIVERABLE

Do Not Distribute to DTIC or other data depositories

Distribution Limited to DOD and DOD Contractors Only

Premature dissemination (date* statement applied).
Other request shall be referred to:

Commanding Officer
SPACE AND NAVAL WARFARE SYSTEMS CENTER
Code 20271
SAN DIEGO, CA 92152-5001

*Proper date to be determined by Program Manager and affixed by contractor

Marking on documents shall be applied as follows:

- | | |
|---|---|
| Written or Printed Material with Covers and/or Title pages: | Statement printed, typed or stamped on front cover and title page. |
| Documents without Covers/Title pages: | Statement typed, printed or stamped on first page. |
| Drawings: | Statement typed, printed or stamped near title block. |
| Magnetic tape, cassette, or disk: | Statement typed, printed or stamped on a label affixed to outside of media. Also, the First and Last Pages or resulting hard-copy report or computer printout must be marked with the same statement as appears on the label. |
| Microfilm: | Statement typed, printed, or stamped on outside of jacket or canister housing the material. Also, the First and Last Pages of resulting hard-copy and the First and Last frames must be marked with the statement. Microfiche headers must contain an abbreviated version of the statement. |